



## **Datasheet**

# AC/DC/IR/GB Electrical Safety Analyzer

Stock No.: Model:
2010450 RSST-2004
2010449 RSST-2003
2010448 RSST-2002
2010446 RSST-2001





#### **FEATURES**

- Comply with IEC 61010-2-034
- 7" TFT LCD
- Manual / Auto Mode
- True RMS Current Measurement
- Zero Crossing Turn-on Operation
- Controllable Ramp-up & Ramp-down Time
- Capacitive Load Testing Capability up to 47μF
- Statistics Function
- Sweep Function for DUT Characteristic Analysis
- USB Storage Available
- Rear Panel Output Available
- Interface: RS-232C, USB Host/Device, Signal I/O
- Universal Power Input





RS PRO introduces the flagship model (200VA output capacity) safety analyzer-the RSST-2000 series, which is the first safety analyzer in the world to comply with IEC 61010-2-034 (Safety requirement for electrical requirement for measurement, control and laboratory use – particular requirements for measurement equipment for insulation resistance and test equipment for electric strength), which stipulates that the requirements of the software and hardware interfaces must be followed while designing high voltage and insulation resistance test and measurement instruments so as to ensure that users are provided with necessary protection and warning while using the instruments.

The RSST-2000 series safety analyzer has four models: RSST-2004 features AC/DC withstanding voltage test, insulation resistance test, AC ground bond test and continuity test; RSST-2003 conducts AC/DC withstanding voltage test, insulation resistance test, and continuity test; RSST-2002 carries out AC/DC withstanding voltage test and continuity test; RSST-2001 executes AC withstanding voltage test and continuity test. The entire series provides an output capacity of 200VA and utilizes a high-efficient PWM amplifier to effectively exclude the influence from the fluctuating input voltage or distorted waveforms so as to guarantee a stable high-voltage output while conducting AC withstanding voltage test on the DUT to meet the safety regulations such as IEC \cdot EN \cdot UL \cdot CSA \cdot GB \cdot JIS that demand the test requirements for various electronic/electrical products or parts.

To comply with IEC 61010-2-034 requirements, the series takes into account of safety by adopting the double insulation design for input power supply and output voltage to enhance user safety. Additionally, the retracted on-off switch design (START key) and various (optional) mechanisms for test activation (for instance, press and hold for 1 second to activate, activation by pressing double keys, etc.) are incorporated into the series to avoid accidentally touching that results in high voltage/large current output causing damage and danger to products or users. High illumination LED lights (flashing or permanently lit) and a high volume audial indicator are included in designing the series to provide warnings of the status of the on-going tests or judgement results from the safety analyzer. On top of that, the DUT will be automatically discharged to the safe voltage (approximately 30V) after each test to prevent large residual test voltage from causing harm to users.

The series utilizes 7-inch color TFT LCD and inherits the consistent simplicity key design style of the product family to allow users to experience easy operations and a clear observation of the test results. The major test functions include AC withstanding voltage test (AC 5kV/40mA), DC withstanding voltage test (DC 6kV/10mA), insulation resistance test (DC 50V~1200V/50G $\Omega$  max.), ground bond test (AC 32A/650m $\Omega$  max.), and grounding continuity test (DC 100mA fixed/70 $\Omega$  max.). The series also collocates with superb output adjustment resolution, measurement resolution (AC withstanding voltage: 1 $\mu$ A; DC withstanding voltage: 0.1 $\mu$ A; insulation resistance: 0.1M $\Omega$ ; ground bond: 0.1M $\Omega$ ; continuity test: 0.01 $\Omega$ ), controllable voltage ramp up and ramp down time settings, and upper/lower limit judgement settings, and large capacitance test capability (up to 47 $\mu$ F) for DUT with large capacitance such as surge absorber and large capacitance on the input terminal of EMC/EMI prevention. For Insulation resistance, provides 10mA pre-charged current (fixed) to first rapidly fully charge the DUT's capacitive load and then to conduct test and measurement so as to avoid misjudgment from fluctuating inrush current. All the above features of the series facilitate a more flexible execution of the required tests so that users can obtain accurate test and measurement results.

The statistic function is the highlight of the series. Test items, number of tests, judgement results are recoded after testing and the test results can be shown by bar graph on the display. Users can immediately learn the status of product tests and judgement distribution during the manufacturing process without using a PC. The other strong feature is the sweep function, which can be used for the analysis on product's crash point. Users can use the sweep mode to see the curve diagram of the test results after finishing the functional tests. Users can also select any time point during the process to analyze the relation between voltage and current (when ACW or DCW is selected). The test result of the certain period of time can be swept by setting start and stop time points to analyze the relation between voltage and current under that time frame. Furthermore, the tabular continuity test function can combine 10 manual memory sets to carry out automatic tests or 9 manual memory sets with one connection device to connect next automatic test so as to increase the test items of the continuity test. Users can obtain various test values and judgement results without switching to a different display screen.

Other functions and features of the RSST-2000 series include 100 sets of manual test memory for the storage of different test conditions; rear output terminal for system integration; front panel remote control terminal mount/rear panel Signal I/O for users to conveniently control the analyzer's output/stop based upon the requirements. The USB storage function allows test results to be stored in the USB flash drive to save the trouble of using a PC, and the function is conducive to the follow-up data analysis. For users with the requirements of PC control and test results recording, the series also provides RS-232C, USB.

#### PANEL INTRODUCTION





- 1. Start & Stop Button
- 2. Function Selection Key
- 3. 7" LCD Display
- 4. Navigator Key
- 5. Status Indicator (PASS/FAIL)
- 6. Wheel & Test Mode key
- 7. USB Host
- 8. REMOTE Terminal
- 9. Hi-Voltage Output Terminal & Indicator
- 10. Current Output Terminal & Return
- 11. Rear Output Terminal & Indicator
- 12. Series Port (RS-232C/USB device)
- 13. Signal I/O





SPECIFICATIONS	
AC WITHSTANDING	
Output-Voltage Range	0.050kV~5.000kV
Output-Voltage Resolution	0.050kV~5.000kV
Output-Voltage Accuracy	$\pm (1\% \text{ of setting} + 5\text{V}) \text{ [no load]}$
Maximum Rated Load	200 VA (5kV/40mA)
Maximum Rated Current	40mA (0.5kV< V≤5kV); 10mA (0.05kV≤ V≤0.5kV)
Output-Voltage Waveform	Sine wave
Output-Voltage Frequency	50 Hz / 60 Hz selectable
Voltage Regulation	±(1% + 5V) [maximum rated load no load]
Voltmeter Accuracy	±(1% of reading + 5V)
Current Measurement Range	1μA~40.00mA
Current Best Resolution	1μΑ / 10μΑ
Current Measurement Accuracy	$\pm (1.5\% \text{ of reading} + 30\mu\text{A})$
Window Comparator Method	Yes
ARC Detect	Yes 0.1s~999.9s
RAMP UP (Rise Time) RAMP DOWN (Fall Time)	0.15~7575.5 0.05~999.9s
TIMER (Test Time)*	OFF, 0.3s~999.9s
WAIT TIME	0.0s-999.9s
GND	ON/OFF
DC WITHSTANDING	1.1.71
Output-Voltage Range	0.050kV~6.000kV
Output-Voltage Resolution	1V
Output-Voltage Accuracy	$\pm$ (1% of setting + 5V) [no load]
Maximum Rated Load	50W (5kV/10mA)
Maximum Rated Current	$10mA (0.5kV < V \le 6kV); 2mA (0.05kV \le V \le 0.5kV)$
Voltage Regulation	±(1% + 5V) [maximum rated load no load]
Voltmeter Accuracy	±(1% of reading + 5V)
Current Measurement Range	1μA~10.00mA
Current Best Resolution	0.1µA /1µA /10µA
Current Measurement Accuracy	±(1.5% of reading + 3µA) when I Reading < 1mA; ±(1.5% of reading + 30µA) when I Reading≧1mA
Window Comparator Method	Yes
ARC Detect	Yes
RAMP UP (Rise Time)	0.1s~999.9s
RAMP DOWN (Fall Time)	0.05-999.9s
TIMER (Test Time)*	OFF, 0.3s~999.9s
WAIT TIME	0.0s~999.9s ON/OFF
GND INSULATION RESISTANCE	
	FOU FOOUL
Output Voltage	50V~5000V dc 50V
Output-Voltage Resolution Output-Voltage Accuracy	$\pm (1\% \text{ of setting} + 5\text{V}) \text{ [no load]}$
	Measurement Range / Accuracy
50V≦V≦100V 0.1MΩ~10.00GΩ 150V≦V≤450V 0.1MΩ~20.00GΩ	0.1MΩ~1MΩ : $\pm$ (5% of reading + 3 count); 1 MΩ~50MΩ : $\pm$ (5% of reading + 1 count); 51MΩ~2GΩ : $\pm$ (10% of reading + 1 count)
150V ≤ V ≤ 450V 0.1MΩ 220.00GΩ 500V ≤ V ≤ 1200V 0.1MΩ 250.00GΩ	$0.1MΩ \sim 1MΩ : \pm (5\% \text{ of reading} + 1 \text{ count});$ $0.1MΩ \sim 1MΩ : \pm (5\% \text{ of reading} + 3 \text{ count});$ $0.1MΩ \sim 1MΩ : \pm (5\% \text{ of reading} + 1 \text{ count});$
$77900.0C \sim 71M11.0  0.0071 \Rightarrow b \Rightarrow 0.0077$	$0.1M\Omega \sim 1M\Omega$ : $\pm (5\% \text{ of reading} + 3 \text{ count})$ ; $1M\Omega \sim 500M\Omega$ : $\pm (3\% \text{ of reading} + 1 \text{ count})$ ; $501M\Omega \sim 9.999G\Omega$ : $\pm (10\% \text{ of reading} + 1 \text{ count})$
Voltage Regulation	±(1% + 5V) [maximum rated load no load]
Voltage Regulation Voltmeter Accuracy	±(1% + 5V) [maximum rateu load 10 load] ±(1% of reading + 5V)
Short-Circuit Current	10mA max.
Output Impedance	$10\text{mA max}.$ $2k\Omega$
Output Impedance Window Comparator Method	
Output Impedance Window Comparator Method RAMP UP (Rise Time)	2kΩ Yes 0.1s-999.9s
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time)	$ \begin{array}{c} 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.0s-999.9s \\ \end{array} $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)*	$ 2k\Omega \\ Yes \\ 0.1s \sim 999.9s \\ 0.0s \sim 999.9s \\ 0.3s \sim 999.9s $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME	2kΩ Yes 0.1s-999.9s 0.os-999.9s 0.os-999.9s
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND	$ 2k\Omega \\ Yes \\ 0.1s \sim 999.9s \\ 0.0s \sim 999.9s \\ 0.3s \sim 999.9s $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND	2kΩ Yes 0.1s-999.9s 0.0s-999.9s 0.3s-999.9s 0.0s-999.9s ON/OFF
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current	2kΩ Yes 0.1s-999.9s 0.3s-999.9s 0.3s-999.9s ON/OFF
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution	2kΩ Yes 0.1s-999.9s 0.0s-999.9s 0.0s-999.9s ON/OFF 03.00A-32.00A ac 0.01A
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy	$2k\Omega$ Yes $0.1s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.00A$ $0.01A$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage	$2k\Omega$ Yes $0.1s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.NOFF$ $0.0s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.3oA-32.00A$ ac $0.01A$ $0.08 = 0.08 = 0.08$ $0.08$ $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Frequency	$2k\Omega$ Yes $0.1s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.N/OFF$ $03.00A-32.00A$ ac $0.01A$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range	2kΩ  Yes $ 0.1s-999.9s $ $ 0.3s-999.9s $ $ 0.0s-999.9s $ $ 0.0s-999.9s $ $ 0.NOFF $ $ 03.00A-32.00A ac $ $ 0.1A $ $ 3A ≤  ≤ 8A : ±(1% of reading + 0.2A);  8A <  ≤ 32A : ±(1% of reading + 0.05A) $ $ 8Vac max  (open circuit) $ $ 50Hz/60Hz  selectable $ $ 1mΩ - 650mΩ$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution	2kΩ Yes $0.1s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $ON/OFF$ $0.300A-32.00A ac$ $0.01A$ $3A ≤ 1 ≤ 8A : ±(1% of reading + 0.2A); 8A < I ≤ 32A : ±(1% of reading + 0.05A)$ 8Vac max (open circuit) 50Hz/60Hz selectable $1mΩ - 650mΩ$ $0.1mΩ$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.NOFF $ $ 03.00A-32.00A ac \\ 0.01A \\ 3A ≤ ≤ 8A : ±(1% of reading + 0.2A); 8A < I ≤ 32A : ±(1% of reading + 0.05A) \\ 8Vac max (open circuit) \\ 50Hz/60Hz selectable \\ 1mΩ − 650mΩ \\ 0.1mΩ \\ ±(1% of reading + 2 mΩ) $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.NOFF $ $ 0.300A-32.00A ac \\ 0.01A \\ 3A ≤  ≤ 8A : ±(1% of reading + 0.2A); 8A<  ≤ 32A : ±(1% of reading + 0.05A) \\ 8Vac max (open circuit) \\ 50Hz/60Hz selectable \\ 1mΩ - 650mΩ \\ 0.1mΩ \\ ±(1% of reading + 2 mΩ) \\ Yes $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.NOFF $ $ 03.00A-32.00A ac \\ 0.01A \\ 3A ≤ ≤ 8A : ±(1% of reading + 0.2A); 8A < I ≤ 32A : ±(1% of reading + 0.05A) \\ 8Vac max (open circuit) \\ 50Hz/60Hz selectable \\ 1mΩ − 650mΩ \\ 0.1mΩ \\ ±(1% of reading + 2 mΩ) $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)*	2kΩ Yes $0.1s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.N/OFF$ $0.300A-32.00A ac$ $0.11A$ $3A ≤ I ≤ 8A : ±(1% of reading + 0.2A); 8A < I ≤ 32A : ±(1% of reading + 0.05A)$ $8Vac max (open circuit)$ $50H2/60H2 selectable$ $1mΩ - 650mΩ$ $0.1mΩ$ $±(1% of reading + 2 mΩ)$ Yes $0.3s-999.9s$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ ON/OFF $ $ 0.00A-32.00A ac \\ 0.01A \\ 3A ≤   ≤ 8A : ±(1% of reading + 0.2A);  8A<  ≤ 32A : ±(1% of reading + 0.05A) $ 8Vac max (open circuit) $ 50Hz/60Hz $ selectable $ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ ±(1% of reading + 2 mΩ) $ Yes $ 0.3s-999.9s \\  Four Terminal $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST	$2k\Omega$ Yes $0.1s-999.9s$ $0.0s-999.9s$ $0.3s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0r-999.9s$ $0.0r-9999.9s$ $0.0r-9999.9s$ $0.0r-99999999999999999999999999999999999$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.3s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ ON/OFF $ $ 03.00A-32.00A ac \\ 0.01A \\ 3A ≤   ≤ 8A : ± (1% of reading + 0.2A); 8A<1 ≤ 32A : ± (1% of reading + 0.05A) \\ 8Vac max (open circuit) \\ 50H2/60H2 selectable \\ 1mΩ - 650mΩ \\ 0.1mΩ \\ ± (1% of reading + 2 mΩ) \\ Yes \\ 0.3s-999.9s \\ Four Terminal \\ ON/OFF $ $ 100mA dc (fixed) \\ 0.10Ω - 70.00Ω $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Output-Current Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.NOFF $ $ 03.00A-32.00A ac \\ 0.01A \\ 3A ≤  ≤ 8A : ±(1% of reading + 0.2A); 8A< ≤ 32A : ±(1% of reading + 0.05A) \\ 8Vac max (open circuit) \\ 50H±/60Hz selectable \\ 1mΩ-650mΩ \\ 0.1mΩ \\ ±(1% of reading + 2 mΩ) \\ Yes \\ 0.3s-999.9s \\ Four Terminal \\ ON/OFF $ $ 100mA dc (fixed) \\ 0.10Ω-70.00Ω \\ 0.01Ω $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Output-Current Output-Current Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Resolution	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.N/OFF$ $0.16$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND  GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ommeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Range	$ 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.3s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ ON/OFF \\ \hline \\ 03.00A-32.00A ac \\ 0.01A \\ 3A \leqq l \leqq 8A : \pm (1\% \text{ of reading} + 0.2A); \ 8A < l \leqq 32A : \pm (1\% \text{ of reading} + 0.05A) \\ 8Vac \max \text{ (open circuit)} \\ 50H \pm / 60H^2 \text{ selectable} \\ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ \pm (1\% \text{ of reading} + 2 m\Omega) \\ \text{Yes} \\ 0.3s-999.9s \\ \text{Four Terminal} \\ ON/OFF \\ \hline \\ \hline \\ 100mA dc \text{ (fixed)} \\ 0.10\Omega - 70.00\Omega \\ 0.01\Omega \\ \pm (1\% \text{ of reading} + 2 \Omega) \\ \text{Yes} \\ \hline $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Racoultion Ohmmeter Measurement Racouracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Recolution Ohmmeter Measurement Recolution IMER (Test Time)*	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.N/OFF$ $0.16$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* MEMORY	$ 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0N/OFF \\ \hline \\ 03.00A-32.00A \ ac \\ 0.01A \\ 3A \le   s A_1 : \pm (1\% \ of \ reading + 0.2A); \ 8A <   \le 32A : \pm (1\% \ of \ reading + 0.05A) \\ 8Vac \ max \ (open \ circuit) \\ 50Hz/60Hz \ selectable \\ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ \pm (1\% \ of \ reading + 2 \ m\Omega) \\ Yes \\ 0.3s-999.9s \\ Four \ Terminal \\ ON/OFF \\ \hline \\ \hline \\ 100mA \ dc \ (fixed) \\ 0.10\Omega - 70.00\Omega \\ 0.01\Omega \\ \pm (1\% \ of \ reading + 2 \ \Omega) \\ Yes \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Resolution	$2k\Omega$ Yes $0.1s-999.9s$ $0.3s-999.9s$ $0.3s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.0s-999.9s$ $0.00s-999.9s$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Racoution Output-Current Output-Current Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Test Sime)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Time Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Recolution Ohmmeter Measurement Recolution Ohmmeter Measurement Accuracy Window Comparator Method Time Test Time)* MEMORY Single Step Memory Automatic Testing Memory	$ 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0N/OFF \\ \hline \\ 03.00A-32.00A \ ac \\ 0.01A \\ 3A \le   s A_1 : \pm (1\% \ of \ reading + 0.2A); \ 8A <   \le 32A : \pm (1\% \ of \ reading + 0.05A) \\ 8Vac \ max \ (open \ circuit) \\ 50Hz/60Hz \ selectable \\ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ \pm (1\% \ of \ reading + 2 \ m\Omega) \\ Yes \\ 0.3s-999.9s \\ Four \ Terminal \\ ON/OFF \\ \hline \\ \hline \\ 100mA \ dc \ (fixed) \\ 0.10\Omega - 70.00\Omega \\ 0.01\Omega \\ \pm (1\% \ of \ reading + 2 \ \Omega) \\ Yes \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline \\ 0.3s-999.9s \\ \hline $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* MEMORY Single Step Memory Automatic Testing Memory INTERFACE	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.N/OFF$ $0.10\Delta$ $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Ohmmeter Measurement Ohmmeter Measurement Southerd Southe	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Flest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Racoultion Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Range Time Wethod GND CONTINUITY TEST Output-Current Ohmmeter Measurement Resolution Ohmmeter Sesurement Resolution Ohmmeter Sesuremen	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.0s$ -999.9s $0.N/OFF$ $0.10\Delta$ $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Ohmmeter Measurement Ohmmeter Measurement Southerd Southe	$ 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.N/OFF \\ \hline \\ 03.00A-32.00A \ ac \\ 0.01A \\ 3A \le   sA: \pm ( \% \ of \ reading + 0.2A); \ 8A <   \le 32A: \pm (1\% \ of \ reading + 0.05A) \\ 8Vac \ max \ (open \ circuit) \\ 50Hz/60Hz \ selectable \\ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ \pm ( \% \ of \ reading + 2 \ m\Omega) \\ Yes \\ 0.3s-999.9s \\ Four \ Terminal \\ ON/OFF \\ \hline \\ \hline \\ 100mA \ dc \ (fixed) \\ 0.10\Omega - 70.00\Omega \\ 0.01\Omega \\ \pm ( \% \ of \ reading + 2 \ \Omega) \\ Yes \\ 0.3s-999.9s \\ \hline \\ MANU: 100 \ blocks \\ Manu \ per \ auto: 10 \\ BEMOTE, \ USB \ host \\ Rear \ Output, \ RS-232C, \ USB \ device, \ Signal \ I/O, \\ \hline $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND  GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Ohmmeter Measurement Sest Method GND TONINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND TONINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* MEMORY Single Step Memory Automatic Testing Memory INTERFACE Standard (Front) Standard (Rear) DISPLAY	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Flest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Racoultion Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Range Time Wethod GND CONTINUITY TEST Output-Current Ohmmeter Measurement Resolution Ohmmeter Sesurement Resolution Ohmmeter Sesuremen	$ 2k\Omega $ Yes $ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0N/OFF $ $ 03.00A-32.00A ac \\ 0.01A $ $ 3A ≤ 8A : ±(1% of reading + 0.2A);  8A < 1 ≤ 32A : ±(1% of reading + 0.05A) $ $ 8Vac max  (open circuit)                                    $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Test Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* TIMER (Test Time)* MEMORY Single Step Memory Automatic Testing Memory INTERFACE Standard (Front) Standard (Rear) DISPLAY	$ 2k\Omega \\ \text{Yes} \\ 0.1s-999.9s \\ 0.0s-999.9s \\ 0.0s-999.9s \\ 0.N/OFF \\ \hline \\ 03.00A-32.00A \ ac \\ 0.01A \\ 3A \le   sA: \pm ( \% \ of \ reading + 0.2A); \ 8A <   \le 32A: \pm (1\% \ of \ reading + 0.05A) \\ 8Vac \ max \ (open \ circuit) \\ 50Hz/60Hz \ selectable \\ 1m\Omega - 650m\Omega \\ 0.1m\Omega \\ \pm ( \% \ of \ reading + 2 \ m\Omega) \\ Yes \\ 0.3s-99.9s \\ Four \ Terminal \\ ON/OFF \\ \hline \\ \hline \\ 100mA \ dc \ (fixed) \\ 0.10\Omega - 70.00\Omega \\ 0.01\Omega \\ \pm ( \% \ of \ reading + 2 \ \Omega) \\ Yes \\ 0.3s-999.9s \\ \hline \\ MANU: 100 \ blocks, Manu \ per \ auto: 10 \\ \hline \\ MANU: 100 \ blocks, Manu \ per \ auto: 10 \\ \hline \\ REMOTE, USB \ host \\ Rear \ Output, RS-232C, USB \ device, Signal I/O, \\ \hline $
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Ohmmeter Measurement Signature Signature Window Comparator Method TIMER (Test Time)* Test Method GND TONINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* MEMORY Single Step Memory Automatic Testing Memory INTERFACE Standard (Front) Standard (Front) Standard (Rear) DISPLAY	2kΩ Yes 0.1s-999.9s 0.0s-999.9s 0.3s-999.9s 0.S-999.9s 0.ON/OFF   03.00A-32.00A ac 0.01A 3A ≤ ≤ 8A : ±(1% of reading + 0.2A); 8A<1 ≤ 32A : ±(1% of reading + 0.05A) 8Vac max (open circuit) 50Hz/60Hz selectable 1mΩ - 650mΩ 0.1mΩ ±(1% of reading + 2 mΩ) Yes 0.3s-999.9s Four Terminal ON/OFF   100mA dc (fixed) 0.10Ω - 70.00Ω 0.01Ω ±(10% of reading + 2 Ω) Yes 0.3s-999.9s  MANU: 100 blocks AUTO: 100 blocks, Manu per auto: 10  REMOTE, USB host Rear Output, RS-232C, USB device, Signal I/O,  7" color LCD
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND GROUND BOND Output-Current Output-Current Accuracy Test-Voltage Test-Voltage Frequency Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND CONTINUITY TEST Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Ohmmeter Measurement Signature Signature Signature Signature Signature Signature Signature Signature Method TIMER (Test Time)* Test Method Timer Signature	$2k\Omega$ Yes $0.1s$ -999.9s $0.3s$ -999.9s $0.3s$ -999.9s $0.0s$ -999.9s $0.$
Output Impedance Window Comparator Method RAMP UP (Rise Time) RAMP DOWN (Fall Time) TIMER (Fest Time)* WAIT TIME GND  CROUND BOND  Output-Current Output-Current Resolution Output-Current Accuracy Test-Voltage Test-Voltage Test-Voltage Test-Voltage Ohmmeter Measurement Range Ohmmeter Measurement Resolution Ohmmeter Measurement Accuracy Window Comparator Method TIMER (Test Time)* Test Method GND  CONTINUITY TEST  Output-Current Ohmmeter Measurement Range Ohmmeter Measurement Range Test-Voltage Time (Test Time)* Test Method Time (Test Time)* Test Measurement Accuracy Window Comparator Method Time (Test Time)* Time (Test	2kΩ Yes 0.1s-999.9s 0.0s-999.9s 0.3s-999.9s 0.S-999.9s 0.ON/OFF   03.00A-32.00A ac 0.01A 3A ≤ ≤ 8A : ±(1% of reading + 0.2A); 8A<1 ≤ 32A : ±(1% of reading + 0.05A) 8Vac max (open circuit) 50Hz/60Hz selectable 1mΩ - 650mΩ 0.1mΩ ±(1% of reading + 2 mΩ) Yes 0.3s-999.9s Four Terminal ON/OFF   100mA dc (fixed) 0.10Ω - 70.00Ω 0.01Ω ±(10% of reading + 2 Ω) Yes 0.3s-999.9s  MANU: 100 blocks AUTO: 100 blocks, Manu per auto: 10  REMOTE, USB host Rear Output, RS-232C, USB device, Signal I/O,  7" color LCD

### ORDERING INFORMATION

RSST-2004 AC/DC/IR/GB Electrical Safety Analyzer
RSST-2003 AC/DC/IR Electrical Safety Analyzer
RSST-2001 AC/DC/IR Electrical Safety Analyzer
RSST-2001 AC Electrical Safety Analyzer

ACCESSORIES

Quick Start Guide x 1, Power cord x 1, Interlock Key x 1, Remote terminal Cable GHT-119 x 1, Test lead GHT-115 x 1 for RSST-2001/2002/2003, Test lead GHT-115 x 1, GTL-215 x 1 for RSST-2004

